


<b>Search Notes</b>  	<b>Application/Control No.</b>  10553076	<b>Applicant(s)/Patent Under Reexamination</b>  YONEMURA ET AL.
	<b>Examiner</b>  MEIYA LI	<b>Art Unit</b>  2811

SEARCHED			
Class	Subclass	Date	Examiner
361	748,750,761,764,783		
257	787,E21.504,E23.004,E23.036,E23.066,E23.092		
174	250,251,258	6/2/08	ML
	updated	11/19/08	ML
	updated	2/24/09	ML
257	678	7/28/09	
174	256,257,260,268	7/28/09	ML
	updated	10/29/09	ML

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	6/1-2/08	ML
updated	11/19/08	ML
updated	2/24/09	ML
Consulted with Ori Nadav	7/27/09	
updated	7/28/09	ML
updated	10/29/09	ML

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	see attachment	7/28/09	ML
	updated	10/29/09	ML